

Data Sheet January 2000 File Number 3685.2

## 15A, 400V - 600V Hyperfast Diodes

The RHRP1540 and RHRP1560 are hyperfast diodes with soft recovery characteristics ( $t_{rr}$  < 35ns). They have half the recovery time of ultrafast diodes and are silicon nitride passivated ion-implanted epitaxial planar construction.

These devices are intended for use as freewheeling/ clamping diodes and rectifiers in a variety of switching power supplies and other power switching applications. Their low stored charge and hyperfast soft recovery minimize ringing and electrical noise in many power switching circuits reducing power loss in the switching transistors.

Formerly developmental type TA49061.

# **Ordering Information**

PART NUMBER	PACKAGE	BRAND	
RHRP1540	TO-220AC	RHRP1540	
RHRP1560	TO-220AC	RHRP1560	

NOTE: When ordering, use the entire part number.

# Symbol



### **Features**

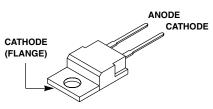
- Hyperfast with Soft Recovery ... <35ns</li>
   Operating Temperature ... ... 175°C
   Reverse Voltage Up To ... ... 600V
- · Avalanche Energy Rated
- Planar Construction

### **Applications**

- · Switching Power Supplies
- · Power Switching Circuits
- General Purpose

### **Packaging**

**JEDEC TO-220AC** 



<b>Absolute Maximum Ratings</b> T <sub>C</sub> = 25°C, Unless Otherwise Specified			
	RHRP1540	RHRP1560	UNITS
Peak Repetitive Reverse Voltage	400	600	V
Working Peak Reverse Voltage	400	600	V
DC Blocking VoltageV <sub>R</sub>	400	600	V
Average Rectified Forward Current $I_{F(AV)}$ ( $T_C = 140^{\circ}C$ )	15	15	Α
Repetitive Peak Surge Current	30	30	Α
Nonrepetitive Peak Surge Current	200	200	Α
Maximum Power Dissipation	100	100	W
Avalanche Energy (See Figures 10 and 11)	20	20	mJ
Operating and Storage Temperature	-65 to 175	-65 to 175	οС

### RHRP1540, RHRP1560

**Electrical Specifications**  $T_C = 25^{\circ}C$ , Unless Otherwise Specified

		RHRP1540		RHRP1560				
SYMBOL	TEST CONDITION	MIN	ТҮР	MAX	MIN	ТҮР	MAX	UNITS
V <sub>F</sub>	I <sub>F</sub> = 15A	-	-	2.1	-	-	2.1	V
	I <sub>F</sub> = 15A, T <sub>C</sub> = 150°C	-	-	1.7	-	-	1.7	V
I <sub>R</sub>	V <sub>R</sub> = 400V	-	-	100	-	-	-	μΑ
	V <sub>R</sub> = 600V	-	-	-	-	-	100	μΑ
	V <sub>R</sub> = 400V, T <sub>C</sub> = 150°C	-	-	500	-	-	-	μА
	V <sub>R</sub> = 600V, T <sub>C</sub> = 150°C	-	-	-	-	-	500	μА
t <sub>rr</sub>	I <sub>F</sub> = 1A, dI <sub>F</sub> /dt = 100A/μs	-	-	35	-	-	35	ns
	I <sub>F</sub> = 15A, dI <sub>F</sub> /dt = 100A/μs	-	-	40	-	-	40	ns
ta	I <sub>F</sub> = 15A, dI <sub>F</sub> /dt = 100A/μs	-	20	-	-	20	-	ns
t <sub>b</sub>	I <sub>F</sub> = 15A, dI <sub>F</sub> /dt = 100A/μs	-	15	-	-	15	-	ns
Q <sub>RR</sub>	I <sub>F</sub> = 15A, dI <sub>F</sub> /dt = 100A/μs	-	40	-	-	40	-	nC
CJ	V <sub>R</sub> = 10V, I <sub>F</sub> = 0A	-	60	-	-	60	-	pF
$R_{ heta JC}$		-	-	1.5	-	-	1.5	°C/W

#### **DEFINITIONS**

 $V_F$  = Instantaneous forward voltage (pw = 300 $\mu$ s, D = 2%).

 $I_R$  = Instantaneous reverse current .

 $t_{rr}$  = Reverse recovery time (See Figure 9), summation of  $t_a$  +  $t_b$ .

 $t_a$  = Time to reach peak reverse current (See Figure 9).

 $t_b$  = Time from peak  $I_{RM}$  to projected zero crossing of  $I_{RM}$  based on a straight line from peak  $I_{RM}$  through 25% of  $I_{RM}$  (See Figure 9).

Q<sub>RR</sub> = Reverse Recovery Change.

 $C_J$  = Junction Capacitance.

 $R_{\theta JC}$  = Thermal resistance junction to case.

pw = Pulse Width.

D = Duty Cycle.

## **Typical Performance Curves**

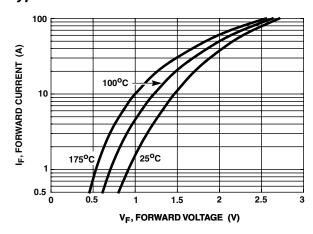


FIGURE 1. FORWARD CURRENT vs FORWARD VOLTAGE

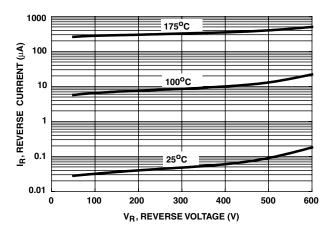


FIGURE 2. REVERSE CURRENT vs REVERSE VOLTAGE

## Typical Performance Curves (Continued)

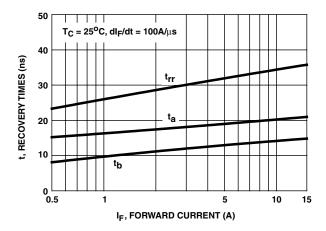


FIGURE 3.  $t_{\rm rr}, t_{\rm a}$  AND  $t_{\rm b}$  CURVES vs FORWARD CURRENT

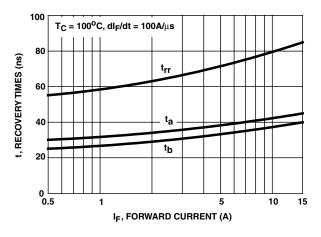


FIGURE 4. t<sub>rr</sub>, t<sub>a</sub> AND t<sub>b</sub> CURVES vs FORWARD CURRENT

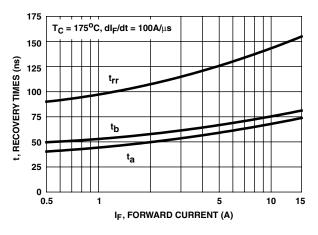


FIGURE 5.  $t_{rr}$ ,  $t_a$  AND  $t_b$  CURVES vs FORWARD CURRENT

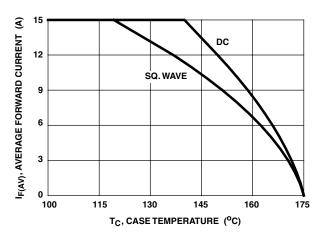


FIGURE 6. CURRENT DERATING CURVE

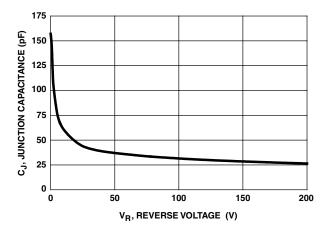


FIGURE 7. JUNCTION CAPACITANCE vs REVERSE VOLTAGE

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# Test Circuits and Waveforms

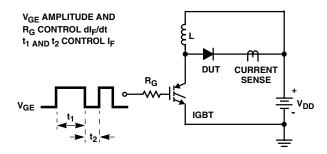


FIGURE 8. t<sub>rr</sub> TEST CIRCUIT

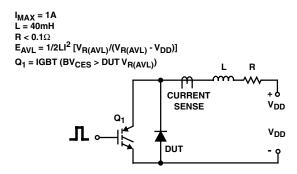


FIGURE 10. AVALANCHE ENERGY TEST CIRCUIT

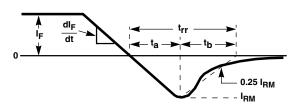


FIGURE 9. t<sub>rr</sub> WAVEFORMS AND DEFINITIONS

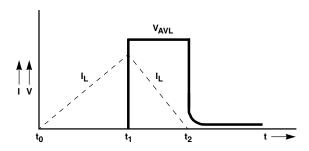


FIGURE 11. AVALANCHE CURRENT AND VOLTAGE WAVEFORMS

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DenseTrench™	HiSeC™	QS™	TinyLogic™
DOME™	ISOPLANAR™	QT Optoelectronics™	UHC <sup>TM</sup>
EcoSPARK™	LittleFET™	Quiet Series™	UltraFET™
$E^2CMOS^{TM}$	MicroFET™	SILENT SWITCHER ®	$VCX^{TM}$
EnSigna™	MICROWIRE™	SMART START™	

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Star\* Power<sup>TM</sup>
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